Notice of References Cited

Application/Control No. 10/711,738	Applicant(s)/Patent Under Reexamination CHEN, JEN-YING	
Examiner	Art Unit	
Sam Dillon	2185	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,787,497	07-1998	Tokura et al.	711/220
*	В	US-5,623,621	04-1997	Garde, Douglas	711/220
*	С	US-5,765,187	06-1998	Shimizu et al.	711/110
*	D	US-4,169,289	09-1979	Shively, Richard R.	710/56
*	Ε	US-6,397,318	05-2002	Peh, Kheng Boon	711/220
*	F	US-6,112,266	08-2000	Yeh, Han C.	710/56
*	G	US-6,044,434	03-2000	Oliver, Richard J.	711/110
*	H	US-6,021,133	02-2000	Asghar, Saf	370/429
	_	US-			
	7	US-			
	Κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	· Name	Classification
	N					
	0					
	Р					
	Q				301. 300	
	R					
	S					
	-1					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.